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# **Advances in Graph-Based Data Mining**

Guest Editor:

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### Message from the Guest Editor

Dear Colleagues,

The Special Issue on "Advances in Graph-Based Data Mining" serves as a platform to explore the forefront of advancements and applications in graph-based techniques within the domain of data mining. It serves a dual purpose: First, it aims to showcase pioneering research that harnesses the intrinsic power of graph structures to derive invaluable insights, uncover patterns, and cultivate knowledge from intricate and interconnected datasets. Second, it aims to foster multidisciplinary collaboration by converging the domains of data mining and graph analytics. By embracing a holistic approach, this Special Issue endeavors to propel our comprehension of intricate data relationships and pave the way for groundbreaking data-driven solutions.

Dr. Kamal Berahmand *Guest Editor* 











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## **Message from the Editor-in-Chief**

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